

Notice of References Cited	Application/Control No. 10/633,415	Applicant(s)/Patent Under Reexamination CHOU ET AL.	
	Examiner Ronald W Leja	Art Unit 2836	Page 1 of 1

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*	B	US-6,683,766	01-2004	Guo et al.	361/42
*	C	US-5,418,463	05-1995	Fleming et al.	324/520
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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